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(54) **ROTATION ANGLE DETECTOR**

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(57) **ABSTRACT**

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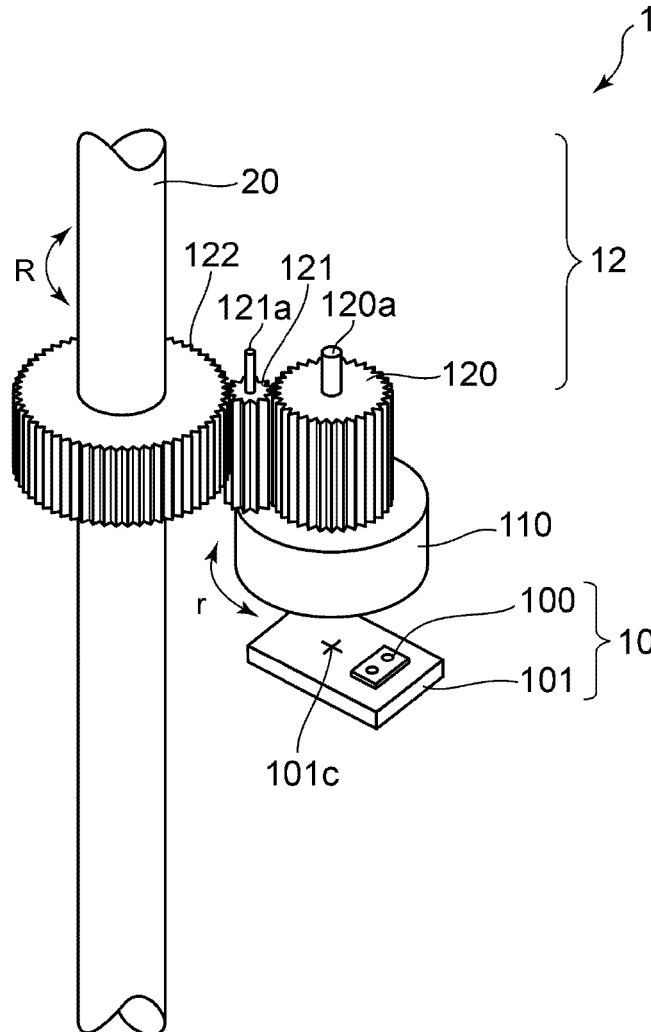
A rotation angle detector includes a magnet arranged to rotate, and a magnetic detection circuit provided with a first pair of magnetic detection elements arranged to be in combination sensitive to a first magnetic field in circumferential direction to the first surface and to a second magnetic field in normal direction to the first surface and arranged away from the rotation axis, and configured to detect magnetic flux of the magnet. A second pair of magnetic detection elements are arranged to be in combination sensitive to the first magnetic field in circumferential direction to the first surface and to the second magnetic field in normal direction to the first surface. A signal processing unit is configured to output a signal representative of a rotation angle of the magnet based on outputs of the first and second pair of magnetic detection elements.

Related U.S. Application Data

(63) Continuation of application No. 17/330,899, filed on May 26, 2021, now Pat. No. 11,656,099, which is a continuation of application No. 16/901,776, filed on Jun. 15, 2020, now Pat. No. 11,067,413, which is a continuation of application No. 16/017,327, filed on Jun. 25, 2018, now Pat. No. 10,718,634.

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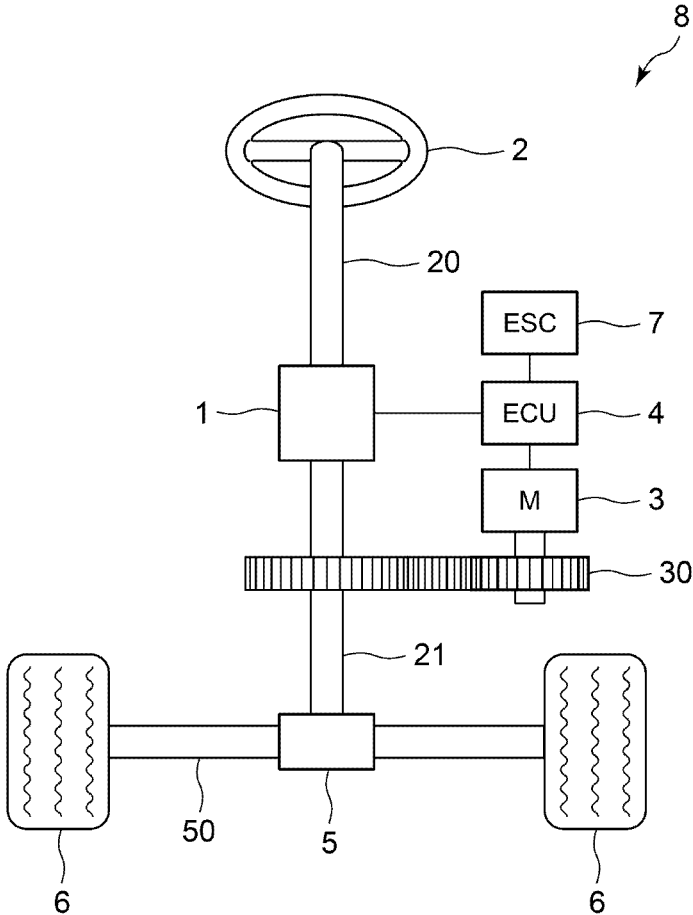


Fig. 1

Fig. 3(a)

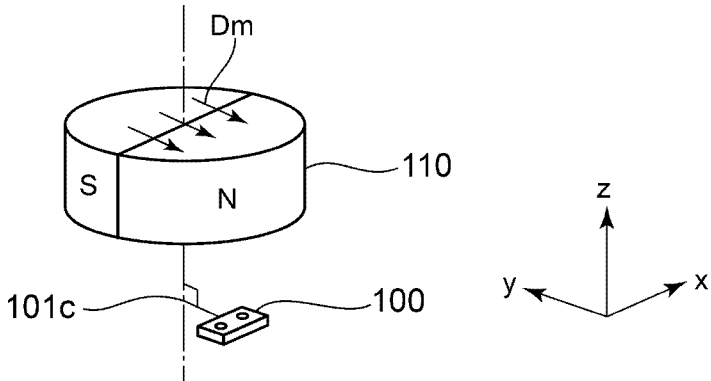


Fig. 3(b)

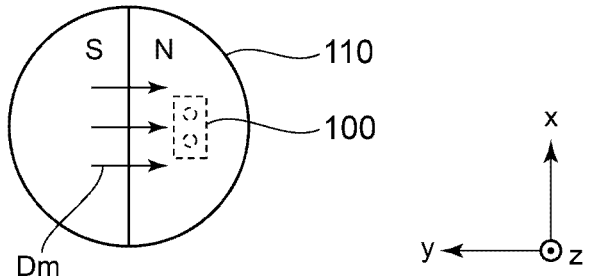
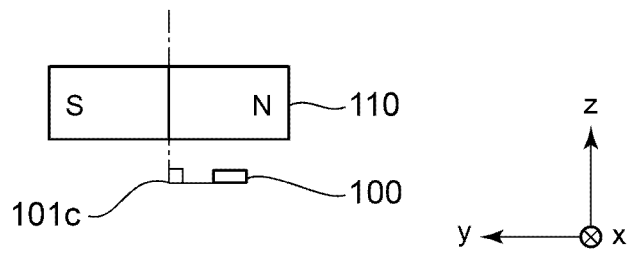
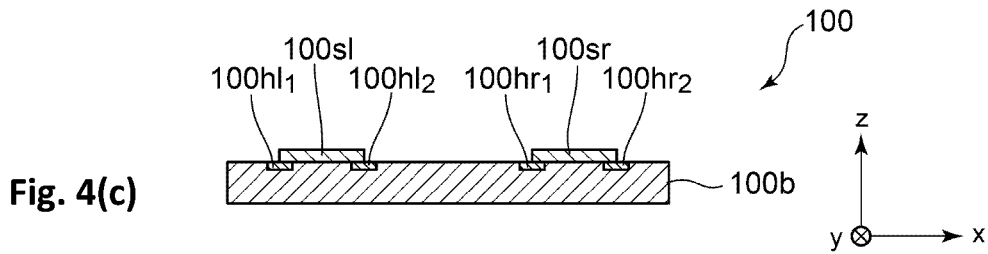
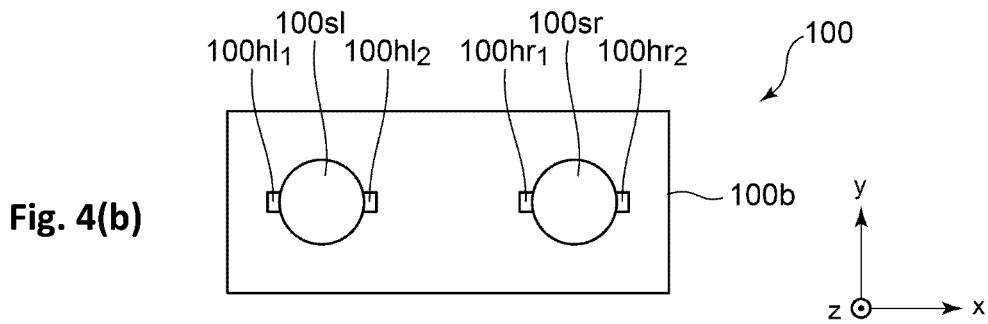
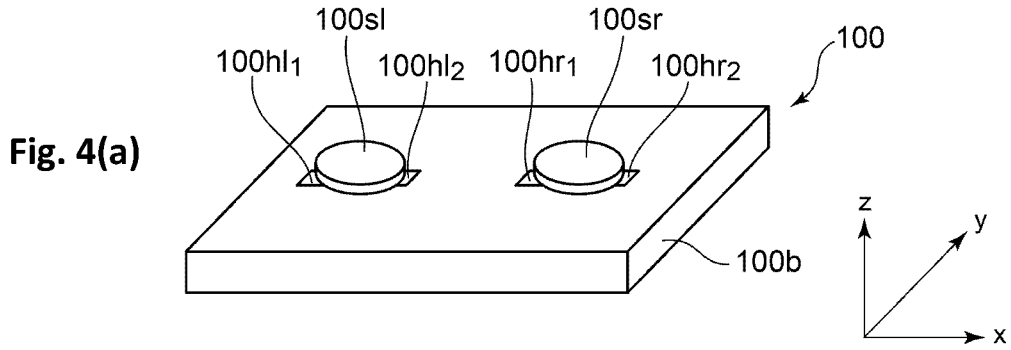


Fig. 3(c)





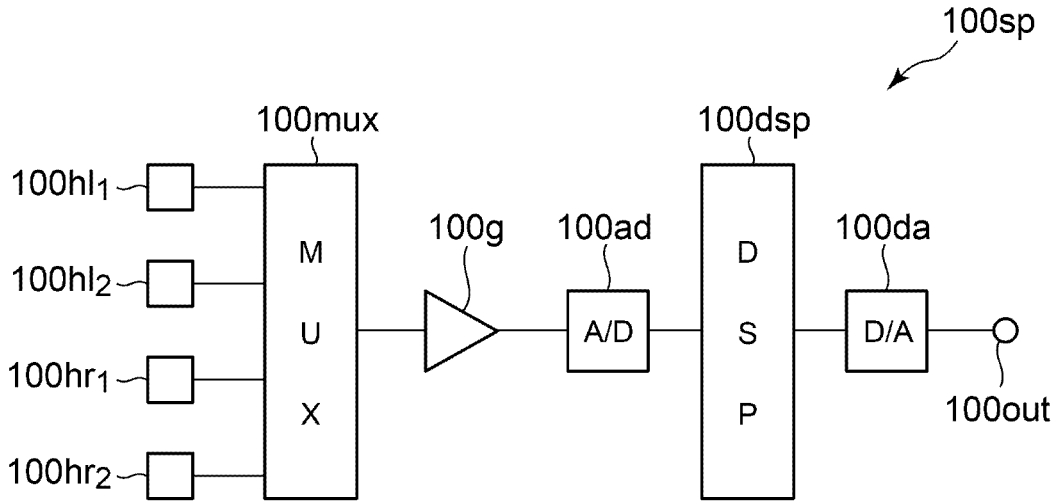


Fig. 5

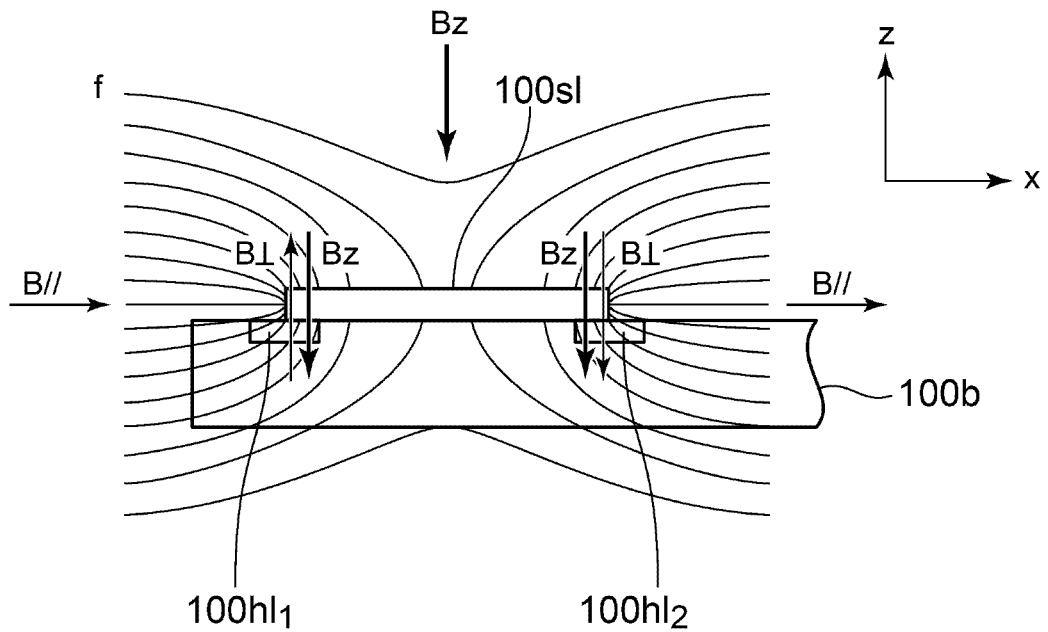


Fig. 6

Fig. 7(a1)

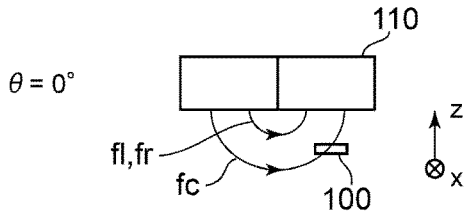


Fig. 7(b1)

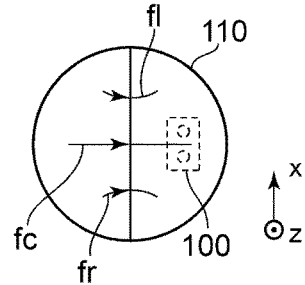


Fig. 7(a2)

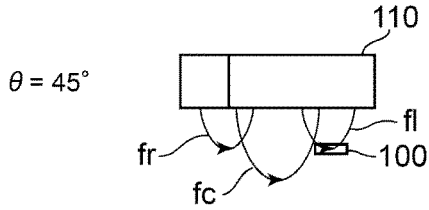


Fig. 7(b2)

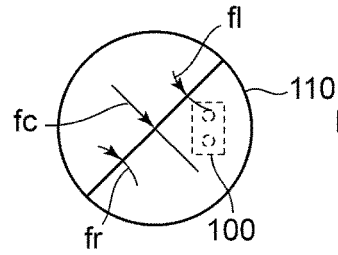


Fig. 7(a3)

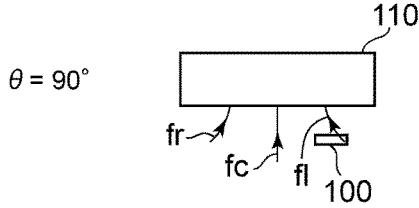


Fig. 7(b3)

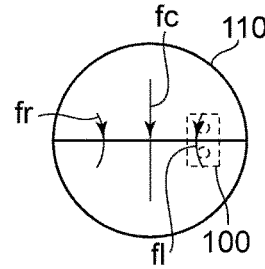


Fig. 7(a4)

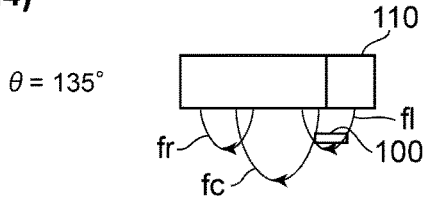


Fig. 7(b4)

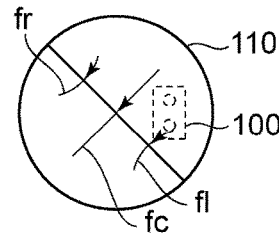


Fig. 7(a5)

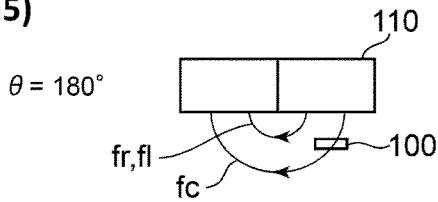
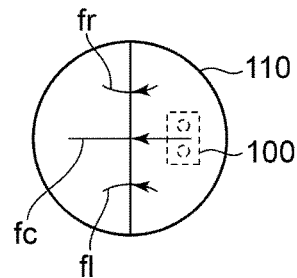


Fig. 7(b5)



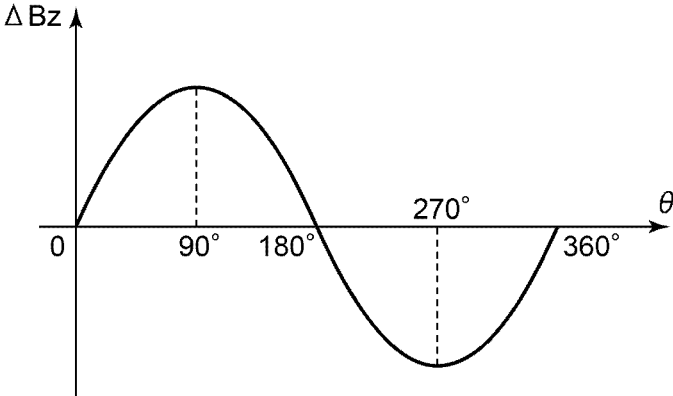


Fig. 8(a)

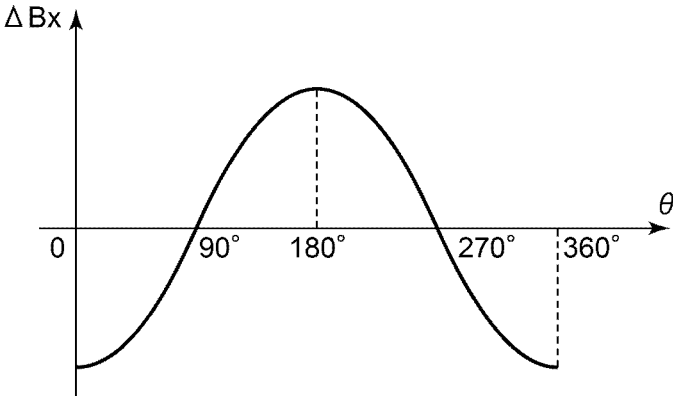


Fig. 8(b)

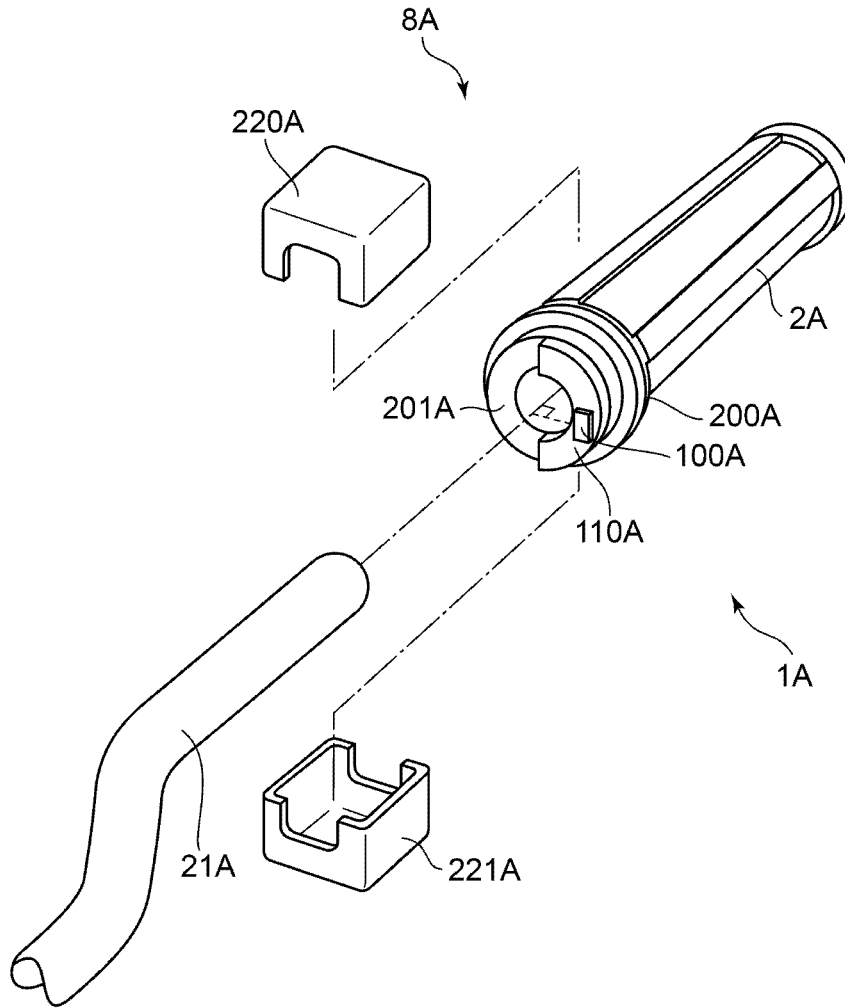


Fig. 9

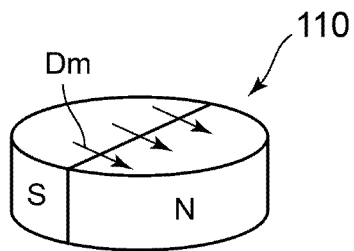


Fig. 10(a)

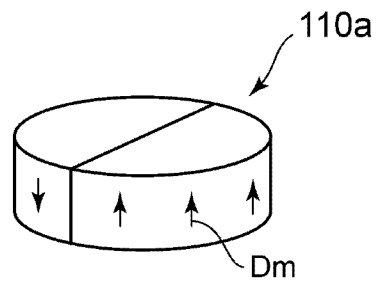


Fig. 10(b)

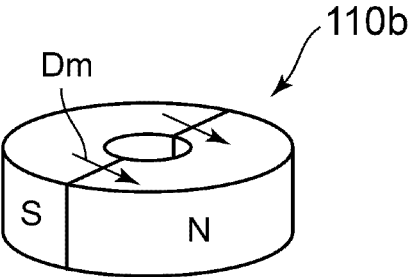


Fig. 11(a)

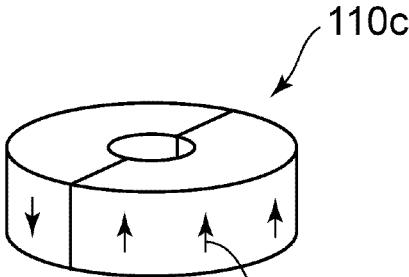


Fig. 11(b)

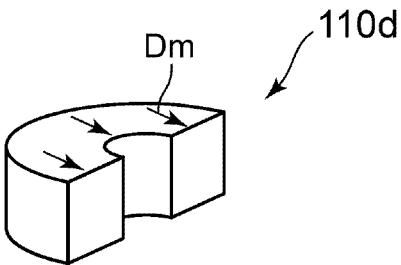


Fig. 12(a)

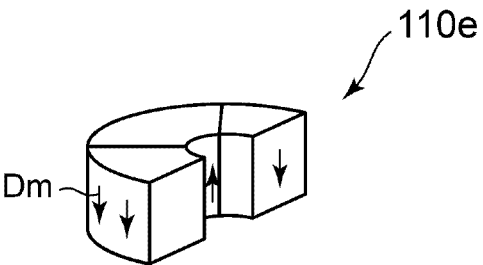
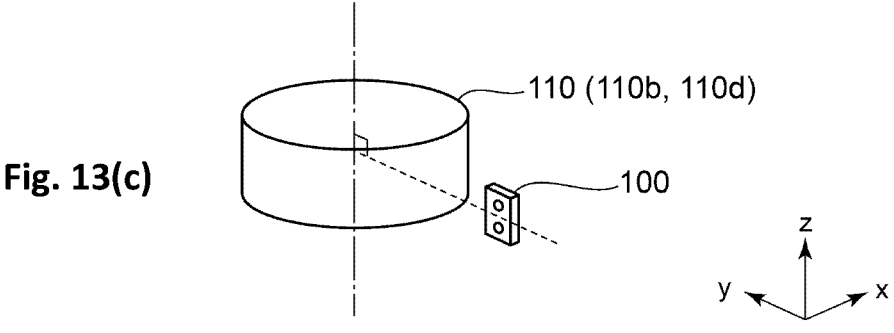
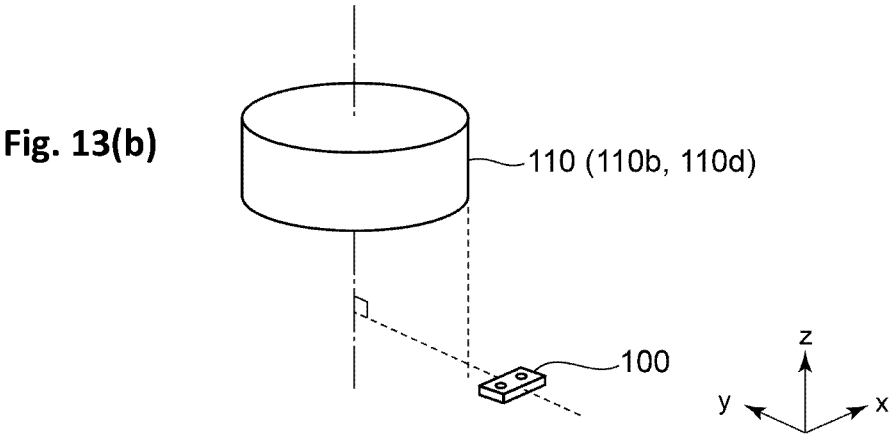
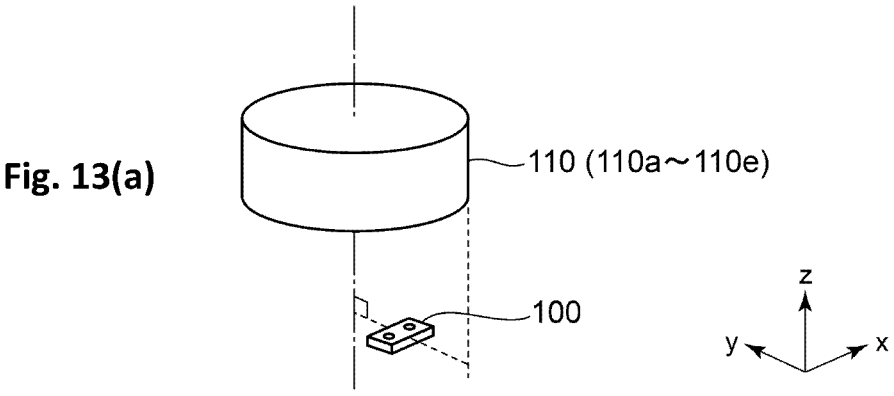


Fig. 12(b)



Rotation angle : 360°
Division : $1/2$

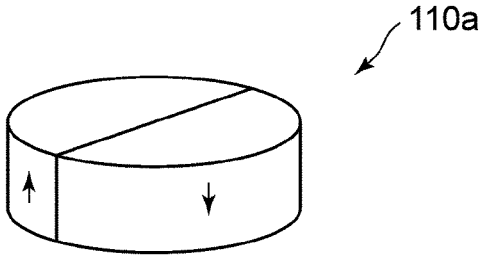


Fig. 14(a)

Rotation angle : 180°
Division : $1/4$

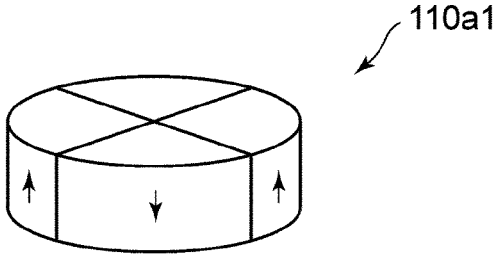


Fig. 14(b)

Rotation angle : 90°
Division : $1/8$

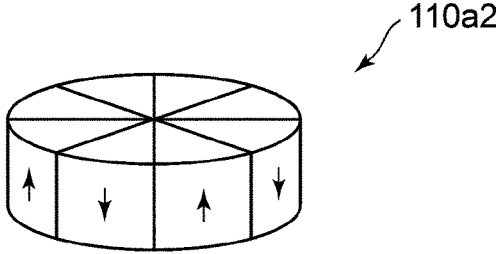


Fig. 14(c)

Fig. 15(a)

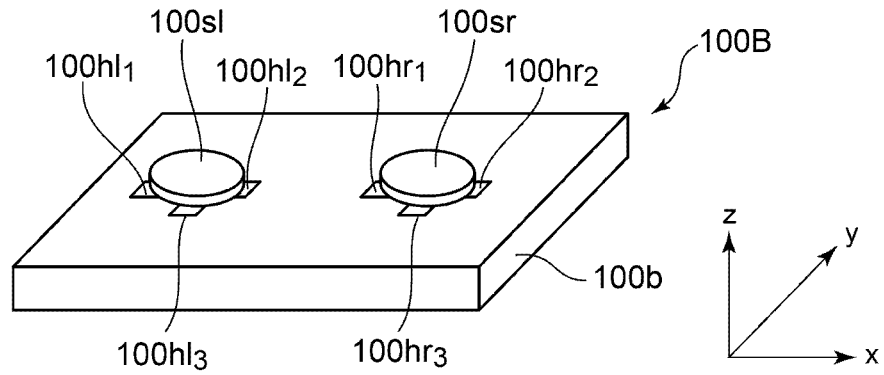


Fig. 15(b)

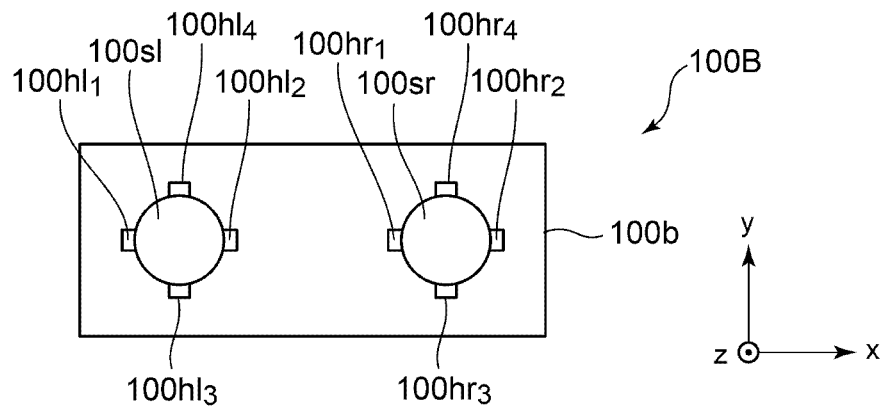
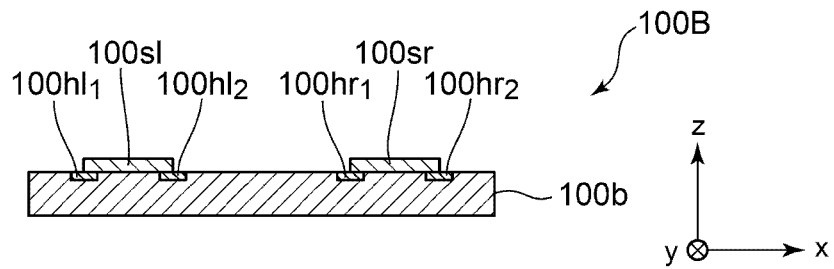


Fig. 15(c)



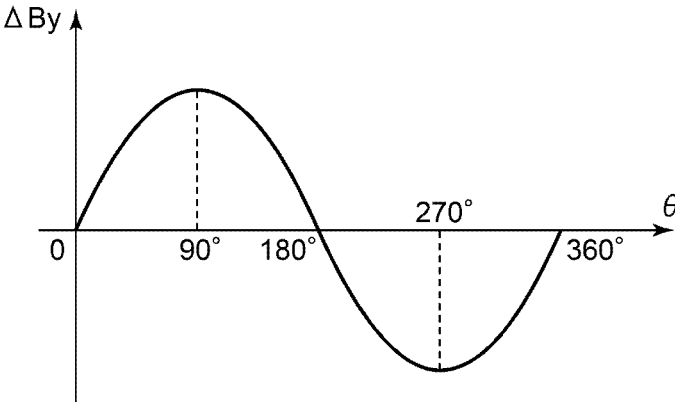


Fig. 16(a)

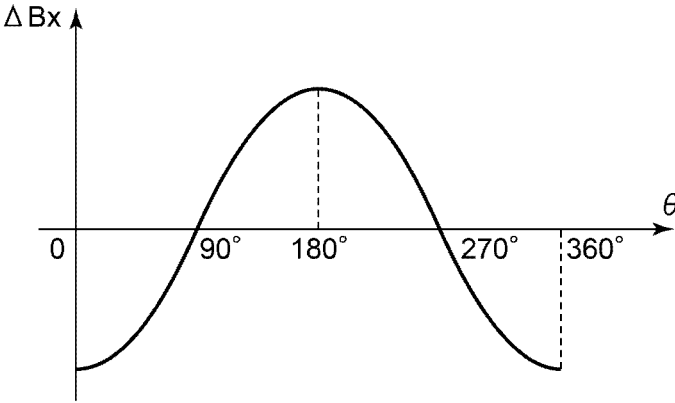


Fig. 16(b)

ROTATION ANGLE DETECTOR

FIELD OF THE INVENTION

[0001] The present invention is generally related to the field of rotation angle detectors, attitude control devices, automatic steering devices and throttle devices.

BACKGROUND OF THE INVENTION

[0002] As a conventional technology, there has been proposed a rotation angle detector that reduces an influence of magnetic noise on an output signal when detecting a direction of a rotating magnetic field (e.g., see JP 2007-10449 A).

[0003] A rotation angle detector disclosed in JP 2007-10449 A or JP 2016-514833 A has a sensor disposed with a pair of magnetic detection elements in a plurality of directions with respect to a rotating magnetic field, and a signal processing part that processes a signal output from each magnetic detection element of the sensor and outputs a signal corresponding to an angle of the magnetic field. In the rotation angle detector, the signal processing part specifies an influence of magnetic noise by comparing a phase and an amplitude of each output of the pair of magnetic detection elements when the magnetic field is rotated, and outputs a signal with reduced influence of magnetic noise by subtracting the influence of the magnetic noise, or by performing calculation processing such as averaging individual outputs of the pair of magnetic detection elements.

[0004] However, although the rotation angle detector of JP 2007-10449 A or JP 2016-514833 A outputs a signal with reduced influence of magnetic noise, it is necessary to arrange magnetic detection elements in a plurality of directions with respect to the rotating magnetic field, causing a problem that a shape of a sensor cannot be made smaller than at least a region where the magnetic detection elements are disposed. In addition, it is necessary to make a rotation centre of the rotating magnetic field substantially coincide with a centre of the rotation angle detector, causing a problem that an arrangement of the rotation angle detector is limited.

[0005] Hence, there is a need for a rotation angle detector wherein at least one of these drawbacks is avoided or overcome.

SUMMARY OF THE INVENTION

[0006] It is an object of embodiments of the present invention to provide for a rotation angle detector, an attitude control device, an automatic steering device and a throttle device that are to detect a rotation angle, with a reduced size and reduced restriction on the arrangement as compared to conventional ones.

[0007] The above objective is accomplished by the solution according to the present invention.

[0008] In a first aspect the invention relates to the following rotation angle detector, attitude control device, automatic steering device and throttle device. A rotation angle detector according to the invention includes:

[0009] a magnet arranged to rotate; and

[0010] a magnetic detection IC provided with a first pair of magnetic detection elements that have a normal line of a detection surface in parallel with a rotation axis direction of the magnet, are arranged in a region overlapping with the magnet, other than on a rotation axis in a plan view in which the rotation axis direction

is a normal direction, and are configured to detect magnetic flux of the magnet, a second pair of magnetic detection elements arranged with a predetermined interval from the first pair of magnetic detection elements in a circumferential direction of rotation, and a signal processing part configured to output a signal corresponding to a rotation angle of the magnet based on outputs of the first pair of magnetic detection elements and the second pair of magnetic detection elements.

[0011] In a preferred embodiment of the rotation angle detector the signal processing part determines a first magnetic flux density difference in the rotation axis direction and a second magnetic flux density difference in the circumferential direction of the rotation, from outputs of the first pair of magnetic detection elements and the second pair of magnetic detection elements, and outputs a signal corresponding to the rotation angle of the magnet based on the first magnetic flux density difference and the second magnetic flux density difference.

[0012] In the rotation angle detector the signal processing part preferably determines a maximum value of an amplitude of the first magnetic flux density difference and a maximum value of an amplitude of the second magnetic flux density difference based on a rate of change in the amplitudes of the first magnetic flux density difference and the second magnetic flux density difference, and normalizes the amplitude of the first magnetic flux density difference and the amplitude of the second magnetic flux density difference in accordance with the maximum value of the amplitude of the first magnetic flux density difference and the maximum value of the amplitude of the second magnetic flux density difference.

[0013] The invention also relates to a rotation angle detector including:

[0014] a magnet that rotates;

[0015] a magnetic detection IC provided with a first two pairs of magnetic detection elements that have a normal line of a detection surface in parallel with a rotation axis direction of the magnet, are arranged in a region overlapping with the magnet, other than on a rotation axis in a plan view in which the rotation axis direction is a normal direction, and are configured to detect magnetic flux of the magnet, a second two pairs of magnetic detection elements arranged with a predetermined interval from the first two pairs of magnetic detection elements in a circumferential direction of rotation, and a signal processing unit configured to output a signal corresponding to a rotation angle of the magnet based on outputs of the first two pairs of magnetic detection elements and the second two pairs of magnetic detection elements.

[0016] In embodiments of the rotation angle detector the signal processing unit determines a third magnetic flux density difference in a radial direction of the rotation and a second magnetic flux density difference in the circumferential direction of the rotation, from outputs of the first two pairs of magnetic detection elements and the second two pairs of magnetic detection elements, and outputs a signal corresponding to the rotation angle of the magnet based on the third magnetic flux density difference and the second magnetic flux density difference.

[0017] In further embodiments the signal processing unit determines a maximum value of an amplitude of the third

magnetic flux density difference and a maximum value of an amplitude of the second magnetic flux density difference based on a rate of change in the amplitudes of the third magnetic flux density difference and the second magnetic flux density difference, and normalizes the amplitude of the third magnetic flux density difference and the amplitude of the second magnetic flux density difference in accordance with the maximum value of the amplitude of the third magnetic flux density difference and the maximum value of the amplitude of the second magnetic flux density difference.

[0018] In preferred embodiments the magnet has a magnetization direction in a direction orthogonal to the rotation axis.

[0019] In other preferred embodiments the magnet is divided into two parts by a plane passing through the rotation axis and the two parts are parallel to the rotation axis direction and magnetized in mutually opposite directions.

[0020] Advantageously the magnet is divided into a plurality of parts by a plane passing through the rotation axis according to a rotation angle to be detected, and the plurality of parts are parallel to the rotation axis direction and magnetized in mutually opposite directions.

[0021] In certain embodiments the magnet is formed only at a partial angle around a central axis.

[0022] In another aspect the invention also relates to a rotation angle detector including:

[0023] a magnet that rotates;

[0024] a magnetic detection IC provided with a first pair of magnetic detection elements that have a normal line of a detection surface in parallel with a rotation axis direction of the magnet, are arranged in a region not overlapping with the magnet in a plan view in which the rotation axis direction is a normal direction, and are configured to detect magnetic flux of the magnet, a second pair of magnetic detection elements arranged with a predetermined interval from the first pair of magnetic detection elements in a circumferential direction of rotation, and a signal processing unit configured to output a signal corresponding to a rotation angle of the magnet based on outputs of the first pair of magnetic detection elements and the second pair of magnetic detection elements.

[0025] In yet a further aspect the invention relates to a rotation angle detector including:

[0026] a magnet that rotates;

[0027] a magnetic detection IC provided with a first pair of magnetic detection elements that have a normal line of a detection surface in a circumferential direction with respect to a rotation axis of the magnet, are arranged in a region not overlapping with the magnet in a plan view in which the rotation axis direction is a normal direction, are arranged in a region overlapping with the magnet in a plan view in which a direction orthogonal to the rotation axis is a normal line, and are configured to detect magnetic flux of the magnet, a second pair of magnetic detection elements arranged with a predetermined interval from the first pair of magnetic detection elements in a circumferential direction of rotation, and a signal processing unit configured to output a signal corresponding to a rotation angle of the magnet based on outputs of the first pair of magnetic detection elements and the second pair of magnetic detection elements.

[0028] The invention also relates to an attitude control device including the rotation angle detector as previously described.

[0029] The invention also relates to an automatic steering device including the rotation angle detector as previously described.

[0030] The invention also relates to a throttle device including the rotation angle detector as previously described.

[0031] For purposes of summarizing the invention and the advantages achieved over the prior art, certain objects and advantages of the invention have been described herein above. Of course, it is to be understood that not necessarily all such objects or advantages may be achieved in accordance with any particular embodiment of the invention. Thus, for example, those skilled in the art will recognize that the invention may be embodied or carried out in a manner that achieves or optimizes one advantage or group of advantages as taught herein without necessarily achieving other objects or advantages as may be taught or suggested herein.

[0032] The above and other aspects of the invention will be apparent from and elucidated with reference to the embodiment(s) described hereinafter.

BRIEF DESCRIPTION OF THE DRAWINGS

[0033] The invention will now be described further, by way of example, with reference to the accompanying drawings, wherein like reference numerals refer to like elements in the various figures.

[0034] FIG. 1 illustrates a schematic view showing a configuration example of a steering system according to a first embodiment of this invention.

[0035] FIG. 2 is an exploded perspective view showing a configuration example of a rotation angle detector according to the first embodiment.

[0036] FIGS. 3(a) to 3(c) are a perspective view, a plan view and a front view explaining a positional relationship between a Hall IC and a magnet.

[0037] FIGS. 4(a) to 4(c) shows a perspective view, a plan view and a cross-sectional view showing a configuration of the Hall IC.

[0038] FIG. 5 illustrates a block diagram showing a configuration of a signal processing part of the Hall IC.

[0039] FIG. 6 illustrates a schematic cross-sectional view to explain a magnetic-flux detection operation of the Hall IC.

[0040] FIGS. 7(a1) to 7(a5) and 7(b1) to 7(b5) are schematic diagrams showing a relationship between a rotation angle of the magnet and magnetic flux to be detected by the Hall IC. FIGS. 7(a1) to 7(a5) are front views and FIGS. 7(b1) to 7(b5) are plan views.

[0041] FIGS. 8(a) and 8(b) are graphs showing outputs ΔB_z and ΔB_x of the Hall IC, each relative to a rotation angle of the magnet.

[0042] FIG. 9 provides an exploded perspective view showing a configuration example of a rotation angle detector according to a second embodiment.

[0043] FIGS. 10(a) and 10(b) are perspective views showing a modified example of a magnetization direction of the magnet.

[0044] FIGS. 11(a) and 11(b) give perspective views showing modified examples of a shape and a magnetization direction of the magnet.

[0045] FIGS. 12(a) and 12(b) illustrate perspective views providing modified examples of a shape and a magnetization direction of the magnet.

[0046] FIGS. 13(a) to 13(c) are perspective views showing modified examples of an arrangement of the Hall IC.

[0047] FIGS. 14(a) to 14(c) illustrate perspective views showing modified examples of a detection angle and a magnetization direction of the magnet.

[0048] FIGS. 15(a) to 15(c) are a perspective view, a plan view and a cross-sectional view showing a configuration of the Hall IC, according to a third embodiment.

[0049] FIGS. 16(a) and 16(b) illustrates graphs showing outputs ΔB_y and ΔB_x of the Hall IC, each relative to a rotation angle of the magnet.

DETAILED DESCRIPTION OF ILLUSTRATIVE EMBODIMENTS

[0050] The present invention will be described with respect to particular embodiments and with reference to certain drawings but the invention is not limited thereto but only by the claims.

[0051] Furthermore, the terms first, second and the like in the description and in the claims, are used for distinguishing between similar elements and not necessarily for describing a sequence, either temporally, spatially, in ranking or in any other manner. It is to be understood that the terms so used are interchangeable under appropriate circumstances and that the embodiments of the invention described herein are capable of operation in other sequences than described or illustrated herein.

[0052] It is to be noticed that the term “comprising”, used in the claims, should not be interpreted as being restricted to the means listed thereafter; it does not exclude other elements or steps. It is thus to be interpreted as specifying the presence of the stated features, integers, steps or components as referred to, but does not preclude the presence or addition of one or more other features, integers, steps or components, or groups thereof. Thus, the scope of the expression “a device comprising means A and B” should not be limited to devices consisting only of components A and B. It means that with respect to the present invention, the only relevant components of the device are A and B.

[0053] Reference throughout this specification to “one embodiment” or “an embodiment” means that a particular feature, structure or characteristic described in connection with the embodiment is included in at least one embodiment of the present invention. Thus, appearances of the phrases “in one embodiment” or “in an embodiment” in various places throughout this specification are not necessarily all referring to the same embodiment, but may. Furthermore, the particular features, structures or characteristics may be combined in any suitable manner, as would be apparent to one of ordinary skill in the art from this disclosure, in one or more embodiments.

[0054] Similarly it should be appreciated that in the description of exemplary embodiments of the invention, various features of the invention are sometimes grouped together in a single embodiment, figure, or description thereof for the purpose of streamlining the disclosure and aiding in the understanding of one or more of the various inventive aspects. This method of disclosure, however, is not to be interpreted as reflecting an intention that the claimed invention requires more features than are expressly recited in each claim. Rather, as the following claims reflect,

inventive aspects lie in less than all features of a single foregoing disclosed embodiment. Thus, the claims following the detailed description are hereby expressly incorporated into this detailed description, with each claim standing on its own as a separate embodiment of this invention.

[0055] Furthermore, while some embodiments described herein include some but not other features included in other embodiments, combinations of features of different embodiments are meant to be within the scope of the invention, and form different embodiments, as would be understood by those in the art. For example, in the following claims, any of the claimed embodiments can be used in any combination.

[0056] It should be noted that the use of particular terminology when describing certain features or aspects of the invention should not be taken to imply that the terminology is being re-defined herein to be restricted to include any specific characteristics of the features or aspects of the invention with which that terminology is associated.

[0057] In the description provided herein, numerous specific details are set forth. However, it is understood that embodiments of the invention may be practiced without these specific details. In other instances, well-known methods, structures and techniques have not been shown in detail in order not to obscure an understanding of this description.

[0058] FIG. 1 represents a schematic view of a configuration example of a steering system according to a first embodiment. A steering system 8 has a rotation angle detector 1 configured to detect a steering angle of a steering shaft 20 and output a detection signal, a steering wheel 2 connected to one end of the steering shaft 20, a motor 3 configured to rotate a column shaft 21 via a speed reduction gear 30 for automating steering of the steering wheel 2, an electric control unit (ECU) 4 configured to control an operation of the motor 3 in accordance with an output of the rotation angle detector 1, and/or to output information on the steering angle to an electronic stability control (ESC) 7; a pinion gear 5 configured to convert rotational motion of the column shaft 21 into linear motion of a rack shaft 50; a wheel 6 connected to the rack shaft 50 via a tie rod (not shown) or the like; and the ESC 7 configured to stabilize an attitude at a time of turning of a vehicle, to prevent sideslip.

[0059] In the above configuration rotation of the steering wheel 2 by a driver causes rotation of the steering shaft 20 connected to the steering wheel 2. The rotation of the steering shaft 20 causes an accompanying rotation of the column shaft 21. The rotation of the column shaft 21 causes a displacement of the rack shaft 50 via the pinion gear 5, changes an angle of a pair of wheels 6 in accordance with the displacement amount of the rack shaft 50.

[0060] The rotation angle detector 1 detects the steering angle of the steering shaft 20 and outputs a detection signal corresponding to the detected steering angle. When the detection signal is input from the rotation angle detector 1, the ECU 4 calculates the steering angle of the steering shaft 20 in accordance with the detection signal, and outputs information on the steering angle to the ESC 7. The ESC 7 stabilizes an attitude of a vehicle at a time of turning by controlling a brake and an engine output in accordance with the information on the input steering angle.

[0061] Further, in automating the steering of the vehicle the ECU 4 controls the motor 3 in accordance with the detection signal when the detection signal of the rotation angle detector 1 is input. The rotation of the motor 3 is decelerated by the speed reduction gear 30, to rotate the

column shaft **21** to operate the steering wheel **2**. It should be noted that an output of the motor **3** may be directly transmitted to the rack shaft **50** without passing through the column shaft **21**.

[0062] FIG. 2 is an exploded perspective view showing a configuration example of a rotation angle detector **1** according to the first embodiment. FIGS. 3(a) to 3(c) are a perspective view, a plan view and a front view for explaining a positional relationship between a Hall IC **100** and a magnet **110**.

[0063] The rotation angle detector **1** has a magnetic detector **10** mounted with the Hall IC **100** on a substrate **101**, a columnar magnet **110** connected to the steering shaft **20** via a gear part **12**, and configured to rotate in r direction along with rotation of the steering shaft **20** in R direction.

[0064] The magnetic detector **10** is arranged such that a mounting surface of the substrate **101** faces a bottom surface of the magnet **110**. A point **101c** on the substrate **101** is a point that coincides with a rotation axis of the magnet **110**. The Hall IC **100** is arranged at a position offset from the point **101c** with its centre of magnetic detection not coinciding with the point **101c** on the substrate **101**.

[0065] The magnet **110** is magnetized parallel to the bottom surface (upper surface) of a cylindrical column, and rotates magnetization direction D_m along with the rotation in r direction by rotating around a central axis of the cylindrical column as a rotation axis. The rotation of the magnet **110** changes the magnetic field at a magnetic detection point of the Hall IC **100**. A specific change in the magnetic field will be described later in FIGS. 7(a1) to 7(a5) and 7(b1) to 7(b5).

[0066] The gear part **12** includes a gear **120** configured to rotate around a shaft **120a** along with the magnet **110**, a gear **121** configured to rotate around the shaft **121a**, and a gear **122** configured to rotate along with the steering shaft **20**. The gear part **12** is accommodated in a case (not shown), and the shafts **120a** and **121a** are held in holes provided on an inner wall of the case. The magnetic detector **10** may be accommodated in the case or may be disposed outside the case as long as the case is a non-magnetic body.

[0067] As an example, the Hall IC **100** is disposed at a position separated by 5 mm from the bottom surface of the magnet **110**, and at a position separated by 2 mm from the point **101c** in the radial direction.

[0068] The magnet **110** is a permanent magnet formed by using a material such as ferrite, samarium cobalt, neodymium or the like. A size of the magnet is, for example, 10 mm in outer diameter and 5 mm in height.

[0069] FIGS. 4(a) to 4(c) are a perspective view, a plan view and a cross-sectional view showing a configuration of the Hall IC **100**.

[0070] The Hall IC **100** comprises: a substrate **100b**; Hall plates **100hl₁** and **100hl₂** (also collectively referred to as a Hall plate **100hl**) (a first pair of magnetic detection elements) and Hall plates **100hr₁** and **100hr₂** (also collectively referred to as a Hall plate **100hr**) (a second pair of magnetic detection elements) being provided on the substrate **100b** to have a detection surface parallel to the surface of the substrate **100b**, and having a detection direction in a normal direction of the surface of the substrate **100b**, as a magnetic detection element; a magnetic concentrator **100sl** provided on the substrate **100b** to overlap on a part of each of the Hall plates **100hl₁** and **100hl₂**, and configured to convert magnetic flux in the direction orthogonal to the normal direction

into the normal direction to allow the magnetic flux to be detected by the Hall plates **100hl₁** and **100hl₂**; a magnetic concentrator **100sr** provided on the substrate **100b** to overlap on a part of each of the Hall plates **100hr₁** and **100hr₂**, and configured to convert magnetic flux in the direction orthogonal to the normal direction into the normal direction to allow the magnetic flux to be detected by the Hall plates **100hr₁** and **100hr₂**; and a signal processing part (**100sp**, FIG. 5) configured to process signals output from the Hall plates **100hl** and **100hr**, in which the Hall IC **100** detects a magnetic flux density in the normal direction and the direction orthogonal to the normal direction through signal processing described next.

[0071] For example, MLX **90371** or the like made by Melexis Technologies NV is used for the Hall IC **100**, a distance between the Hall plates **100hl₁** and **100hl₂** is 0.2 mm, a thickness is 0.5 mm, a width in y direction is 2 mm, and a width in x direction is 3 mm. For the magnetic concentrator **100sl**, permalloy can be used. Further, the Hall plate **100hl** and the Hall plate **100hr** are separated by 2 mm to be arranged. The widths in x direction and y direction of the Hall IC **100** above are a size in consideration of layout of the signal processing part or the like, and are fitted within a size of 0.2 mm in y direction and 2.4 mm in x direction when only the Hall plate **100hl** and the Hall plate **100hr** are arranged.

[0072] FIG. 5 is a block diagram showing a configuration of a signal processing part of the Hall IC **100**. The signal processing part **100sp** of the Hall IC **100** has: a multiplexer **100mux** configured to sequentially output outputs from the Hall plates **100hl₁**, **100hl₂**, **100hr₁**, and **100hr₂** to subsequent stages; an amplifier **100g** configured to amplify the output of the multiplexer **100mux**; an A/D converter **100ad** configured to convert an analog signal output from the amplifier **100g** into a digital signal; a digital signal processor **100dsp** configured to process the digital signal input from the A/D converter **100ad**; a D/A converter **100da** configured to convert the digital signal output from the digital signal processor **100dsp** into an analog signal; and an output **100out** configured to output the analog signal converted by the D/A converter **100da**, to the ECU **4**.

[0073] The digital signal processor **100dsp** calculates the outputs from the Hall plates **100hl₁**, **100hl₂**, **100hr₁**, and **100hr₂**, and stores necessary information. The digital signal processor **100dsp** adds and subtracts the outputs of the Hall plates **100hl₁** and **100hl₂**, adds and subtracts the outputs of the Hall plates **100hr₁** and **100hr₂**, and then determines a rotation angle of the magnet **110** by using the calculation results. A detailed calculation method will be described later.

[0074] FIG. 6 is a schematic cross-sectional view for explaining a magnetic-flux detection operation of the Hall IC **100**. In the Hall plates of the Hall IC **100**, the Hall plates **100hl₁** and **100hl₂** detect the magnetic flux density in a vertical direction of the drawing. When a horizontal component of the drawing of magnetic flux f is $B_{//}$ (B_x) and a vertical component of the drawing is B_z , horizontal component $B_{//}$ of the drawing is induced by the magnetic concentrator **100s1** and detected as B_{\perp} , so that the Hall plate **100hl₁** detects “ B_{\perp} - B_z ” and the Hall plate **100hl₂** detects “ $-B_{\perp}$ - B_z ”.

[0075] Therefore, a signal proportional to magnetic flux density $2B_{\perp}$ (hereinafter referred to as “ B_xI ”) is obtained by taking a difference between the outputs of the Hall plates **100hl₁** and **100hl₂** with the signal processing part **100sp**, and

a signal proportional to magnetic flux density $-2B_z$ (hereinafter referred to as “Bzl”) is obtained by taking a sum of the outputs of the Hall plates **100hl₁** and **100hl₂**.

[0076] The operation of the Hall plates **100hl₁** and **100hl₂** described above can be similarly explained for the Hall plates **100hr₁** and **100hr₂**. A signal proportional to magnetic flux density $2B_x$ (hereinafter referred to as “Bxr”) is obtained by taking a difference between the outputs of the Hall plates **100hr₁** and **100hr₂** with the signal processing part **100sp**, and a signal proportional to magnetic flux density $-2B_z$ (hereinafter referred to as “Bzr”) is obtained by taking a sum of the outputs of the Hall plates **100hr₁** and **100hr₂**.

[0077] Since the Hall plate **100hl** and the Hall plate **100hr** are arranged separated by 2 mm, the Hall plate **100hl** and the Hall plate **100hr** each detect positionally different magnetic fields. Therefore, the difference between the outputs of the Hall plate **100hl** and the Hall plate **100hr** is calculated as $\Delta B_x = B_{xl} - B_{xr}$ (a second magnetic flux density difference), and $\Delta B_z = B_{zl} - B_{zr}$ (a first magnetic flux density difference). ΔB_x and ΔB_z change along with the rotation angle of the magnet **110**, and their correspondence will be described with reference to FIGS. **7(a1)** to **7(a5)** and **7(b1)** to **7(b5)** and **8(a)** and **8(b)**.

[0078] FIGS. **7(a1)** to **7(a5)** and **7(b1)** to **7(b5)** are schematic diagrams showing a relationship between a rotation angle of the magnet **110** and magnetic flux to be detected by the Hall IC **100**, in which FIGS. **7(a1)** to **7(a5)** are front views and FIGS. **7(b1)** to **7(b5)** are plan views. FIGS. **8(a)** and **8(b)** are graphs showing outputs ΔB_z and ΔB_x of the Hall IC **100**, each relative to the rotation angle of the magnet **110**.

[0079] When the rotation angle of the magnet **110** is $\theta = 0^\circ$ (FIGS. **7(a1)** and **7(b1)**), magnetic fields B_{zl} and B_{zr} detected by the Hall plate **100hl** and the Hall plate **100hr**, respectively, have same numerical values. Therefore, ΔB_z equals 0. Moreover, magnetic fields B_{xl} and B_{xr} detected by the Hall plate **100hl** and the Hall plate **100hr**, respectively, have the same numerical values with reverse signs. Therefore, ΔB_x has a negative maximum value.

[0080] Next, when the rotation angle of the magnet **110** is $\theta = 90^\circ$ (FIGS. **7(a3)** and **7(b3)**), magnetic fields B_{zl} and B_{zr} detected by the Hall plate **100hl** and the Hall plate **100hr**, respectively, have same numerical values with reverse signs. Therefore, ΔB_z has a positive maximum value. Moreover, magnetic fields B_{xl} and B_{xr} detected by the Hall plate **100hl** and the Hall plate **100hr**, respectively, have same numerical values. Therefore, $\Delta B_x = 0$.

[0081] Next, when the rotation angle of the magnet **110** is $\theta = 180^\circ$ (FIGS. **7(a5)** and **7(b5)**), magnetic fields B_{zl} and B_{zr} respectively detected by the Hall plate **100hl** and the Hall plate **100hr** have same numerical values. Therefore, $\Delta B_z = 0$. Moreover, magnetic fields B_{xl} and B_{xr} detected by the Hall plate **100hl** and the Hall plate **100hr**, respectively, have same numerical values with reverse signs (opposite to the case of $\theta = 0^\circ$). Therefore, ΔB_x has a positive maximum value.

[0082] Considering the behaviour of ΔB_z and ΔB_x above, transition states $\theta = 45^\circ$ (FIGS. **7(a2)** and **7(b2)**), $\theta = 135^\circ$ (FIGS. **7(a4)** and **7(b4)**) and $\theta = 180^\circ$ to 360° , a relationship between rotation angle θ of the magnet **110** and ΔB_z and ΔB_x is such that ΔB_z is proportional to $\sin \theta$ and ΔB_x is proportional to $\cos \theta$, as shown in FIGS. **8(a)** and **8(b)**.

[0083] Namely, $\Delta B_z / \Delta B_x = k \cdot \sin \theta / \cos \theta = k \cdot \tan \theta$, so that $\theta = \arctan (K \cdot \Delta B_z / \Delta B_x)$. Note that k is a constant for normalizing a magnitude of the amplitude of ΔB_z and ΔB_x and K is the reciprocal of k .

[0084] The digital signal processor **100dsp** of the signal processing part **100sp** obtains outputs from the Hall plates **100hl₁**, **100hl₂**, **100hr₁** and **100hr₂** as digital signals via the multiplexer **100mux**, the amplifier **100g** and the A/D converter **100ad**, and calculates θ from the outputs obtained based on the above-described calculation method.

[0085] The θ calculated by the digital signal processor **100dsp** is converted from a digital signal to an analog signal by the D/A converter **100da**, and the analog signal converted by the D/A converter **100da** is output from the output **100out** to the ECU **4**.

[0086] Since it is necessary to determine k (or K) for calculating θ , the digital signal processor **100dsp** has a calibration mode for determining k (or K). When the magnet **110** is rotated 360° in the calibration mode, the digital signal processor **100dsp** records ΔB_z and ΔB_x . Next, the digital signal processor **100dsp** calculates k (or K) from the respective maximum values ΔB_{zmax} and ΔB_{xmax} .

[0087] Further, as another example of the method for determining the maximum values ΔB_{zmax} and ΔB_{xmax} , the digital signal processor **100dsp** may determine ΔB_{zmax} and ΔB_{xmax} from differentiation of ΔB_z and ΔB_x (with respect to θ or time), namely, from ΔB_z and ΔB_x of an angle or timing at which an inclination becomes zero.

[0088] According to the above-described embodiment, since the Hall IC **100** detects the rotation of the magnet **110** by using the difference of the magnetic field in x direction and the magnetic field in z direction between two points, the Hall plates only need to be arranged in a single direction with respect to the rotating magnetic field and the Hall plates do not need to be arranged in a plurality of directions, enabling a compact IC compared with a conventional one.

[0089] Further, the Hall IC **100** does not need to be arranged directly under a rotation centre of the magnet **110**, but the Hall IC **100** can be arranged at a position offset from the rotation centre, achieving less restriction on arrangement than a conventional one. In addition, since the Hall IC **100** can be arranged at a position offset from the rotation centre, the gear part **12** can be omitted by providing a cylindrical magnet on the steering shaft **20** and arranging the Hall IC **100** with respect to the magnet. The cylindrical magnet will be described later (FIGS. **11(a)** and **11(b)**).

[0090] A second embodiment is different from the first embodiment in that a magnet **110** has a semicircular cylindrical shape and the range of rotation angles to be detected is 180° . Further, the second embodiment is applied to a throttle device such as a motorcycle or a scooter. The same reference numerals are given to the same configurations as those of the first embodiment.

[0091] FIG. **9** is an exploded perspective view showing a configuration example of a rotation angle detector according to the second embodiment. A throttle device **8A** is, as an example, for controlling rotation of a motor of an electric motorcycle and comprises: a throttle grip **2A** to be gripped by a driver of the electric motorcycle; a cylindrical sleeve **200A** configured to rotate while an outer wall of the cylindrical sleeve **200A** and an inner wall of the throttle grip **2A** are fixed, and an inner wall the cylindrical sleeve **200A** and an outer wall of a handlebar **21A** slide; a mount **201A** provided at one end of the sleeve **200A** and configured to fix

a magnet **110A**; the handlebar **21A** configured to steer the motorcycle; and a switch box **22** including a case upper part **220A** and a case lower part **221A** configured to accommodate a switch, a harness and the like which are not shown, and rotatably hold the sleeve **200A**. The rotation angle detector **1A** according to the second embodiment has a magnetic detector mounted with a Hall IC **100A** on a substrate (not shown) and a semicircular cylindrical magnet **110A** that integrally rotates with the throttle grip **2A**. A configuration of the magnet **110A** including a magnetization direction is shown in FIG. **11(a)** or **11(b)** described later.

[0092] In the above configuration, when a driver of the electric motorcycle rotates the throttle grip **2A**, the sleeve **200A** and the magnet **110A** fixed to the mount **201A** are rotated. The rotation angle detector **1A** detects a rotation angle of the throttle grip **2A** and outputs a detection signal corresponding to the detected rotation angle. When a detection signal is input from the rotation angle detector **1A**, the ECU or the motor control device, which is not shown, calculates a rotation angle and controls the rotation of the motor of the electric motorcycle, in accordance with the detection signal. It should be noted that the throttle grip **2A** and the sleeve **200A** rotate around the handlebar **21A** by less than 180°. FIG. **9** shows a state in which the driver has rotated the throttle grip **2A** by 90°.

[0093] According to the above-described embodiment, the same effects as those of the first embodiment can be applied to a throttle of an electric motorcycle. In other words, the rotation angle detector **1A** with a compact IC as compared with a conventional one can be applied to the throttle device **8A** of the electric motorcycle. Further, since the arrangement position can be offset from the rotation centre and the restriction on arrangement can be reduced as compared with a conventional one, the rotation angle detector **1A** can be used even when the handlebar **21A** occupies a space of the rotation centre.

[0094] Further, since the magnet **110A** is obtained by dividing a cylindrical shape into two parts, the magnet **110A** is easily installed on the handlebar **21A** as compared with a cylindrical magnet (e.g., a magnet **110b** (FIG. **11(a)**) or a magnet **110c** (FIG. **11(b)**)). The rotation angle detector **1A** can be introduced without requiring a design change of the throttle device or as an alternative component of a component constituting a conventional throttle device.

[0095] It should be noted that the present invention is not limited to the embodiment described above. Various modifications can be made without departing from the subject matter of the present invention. For example, the magnet **110** and the magnet **110A** may be replaced with the following.

[0096] FIGS. **10(a)** and **10(b)** are perspective views showing a modified example of a magnetization direction of the magnet. The magnet **110** shown in FIG. **10(a)** is same as the magnet **110** of the first embodiment, and is shown for comparison with a modified example of other magnet. The magnet **110** has magnetization direction D_m in a direction orthogonal to an axis of a cylindrical column in the columnar shape. A magnet **110a** shown in FIG. **10(b)** is obtained by dividing a columnar shape into two parts by a plane passing through the axis of a cylindrical column. Magnetization directions D_m of individual parts are parallel to the axial direction of the cylindrical column and are in mutually opposite directions. Since this configuration causes formation of an external magnetic field equivalent to that of the

magnet **110** at a magnetic detection position of the Hall IC **100**, the magnet **110** may be replaced with the magnet **110a** as it is.

[0097] FIGS. **11(a)** and **11(b)** are perspective views showing modified examples of a shape and a magnetization direction of the magnet. The magnet **110b** shown in FIG. **11(a)** has a cylindrical shape and has magnetization direction D_m in a direction orthogonal to an axis of the cylindrical shape. Since this configuration causes formation of an external magnetic field equivalent to that of the magnet **110** at a magnetic detection position of the Hall IC **100**, the magnet **110** may be replaced with the magnet **110b** as it is. The magnet **110c** shown in FIG. **11(b)** has a cylindrical shape and is obtained by dividing the cylindrical shape into two parts by a plane passing through the axis of the cylinder. Magnetization directions D_m of individual parts are parallel to the axial direction of the cylinder and are in mutually opposite directions. Since this configuration causes formation of an external magnetic field equivalent to that of the magnet **110** at a magnetic detection position of the Hall IC **100**, the magnet **110** may be replaced with the magnet **110c** as it is.

[0098] FIGS. **12(a)** and **12(b)** are perspective views showing modified examples of a shape and a magnetization direction of the magnet. A magnet **110d** shown in FIG. **12(a)** is one of parts obtained by dividing a cylindrical shape by a plane passing through an axis of the cylinder and has magnetization direction D_m in a direction orthogonal to an axis of the cylindrical shape. Since this configuration causes formation of an external magnetic field equivalent to that of the magnet **110** within a range of a rotation angle of 180° where the magnet **110d** and the Hall IC **100** overlap in a plan view with the axis of the cylinder as a normal line, the magnet **110d** may be replaced with the magnet **110d** when being used within the above-described range of the rotation angle. Further, the magnet **110d** can be used as the magnet **110A** of the second embodiment. The magnet **110d** may be formed not only in a semicircle but also at any angle. The rotation angle can be detected with a rotation angle at which the magnet **110d** and the Hall IC **100** overlap in a plan view with the axis of the cylinder as a normal line. A magnet **110e** shown in FIG. **12(b)** is one of the parts obtained by dividing a cylindrical shape by a plane passing through an axis of the cylinder. The shape is further divided into three parts by a plane passing through the axis of the cylinder, in which magnetization directions D_m of individual parts are parallel to the axial direction of the cylinder and are in mutually opposite directions. Since this configuration causes formation of an external magnetic field equivalent to that of the magnet **110** within a range of a rotation angle where the magnet **110e** and the Hall IC **100** overlap in a plan view with the axis of the cylinder as a normal line, the magnet **110e** may be replaced with the magnet **110e** when being used within the above-described range of the rotation angle. Further, the magnet **110e** can be used as the magnet **110A** of the second embodiment. The magnet **110e** may be formed not only in a semicircle but also at any angle. The rotation angle can be detected with a rotation angle at which the magnet **110e** and the Hall IC **100** overlap in a plan view with the axis of the cylinder as a normal line.

[0099] Although the illustrated magnets **110**, **110a** to **110e**, **110a1** and **110a2** are columnar or cylindrical, the shape of the magnets may be any polygonal column shape and is not limited as long as the magnetic flux density to be detected by

the rotation angle detector **1** or **1A** can periodically change and the rotation angle can be uniquely determined with the change.

[0100] Further, the Hall IC **100** and the Hall IC **100A** may be arranged as follows.

[0101] FIGS. **13(a)** to **13(c)** are perspective views showing modified examples of an arrangement of the Hall IC **100**. The arrangement of the Hall IC **100** with respect to the magnet **110** shown in FIG. **13(a)** is same as that in the first embodiment. It is shown for comparison with modified examples of other arrangements of the Hall IC **100**. In this arrangement the magnet **110** may be the magnet **110a** (FIG. **10(b)**), the magnet **110b** (FIG. **11(a)**), the magnet **110c** (FIG. **11(b)**), the magnet **110d** (FIG. **12(a)**) or the magnet **110e** (FIG. **12(b)**). The arrangement of the Hall IC **100** with respect to the magnet **110** shown in FIG. **13(b)** is same as the first embodiment and the second embodiment in that the arrangement of the Hall IC **100** is offset from the axis of the cylindrical column of the magnet **110**. However, it is different in that the offset amount is larger than a radius of the cylindrical column and the magnet **110** and the Hall IC **100** do not overlap each other, even when the magnet **110** is rotated in a plan view in which the axis of the cylindrical column is a normal line. In this arrangement the magnet **110** may be the magnet **110b** (FIG. **11(a)**) or the magnet **110d** (FIG. **12(a)**). The arrangement of the Hall IC **100** with respect to the magnet **110** shown in FIG. **13(c)** is same as the first embodiment and the second embodiment in that the arrangement of the Hall IC **100** is offset from the axis of the cylindrical column of the magnet **110**. However, it is different in that the offset amount is larger than a radius of the cylindrical column, the magnet **110** and the Hall IC **100** do not overlap each other even when the magnet **110** is rotated in a plan view in which the axis of the cylindrical column is a normal line, the magnetic detection direction of the Hall IC **100** is the circumferential direction of the magnet **110** and the arrangement in z direction is between an upper surface and a bottom surface of the cylindrical column of the magnet **110**. In this arrangement the magnet **110** may be the magnet **110b** (FIG. **10(b)**) or the magnet **110d** (FIG. **12(a)**).

[0102] Moreover, the magnet **110** and the magnet **110A** may be replaced with the following, in accordance with a rotation angle to be detected by the rotation angle detector **1** and the rotation angle detector **1A**.

[0103] FIGS. **14(a)** to **14(c)** are perspective views showing modified examples of a detection angle and a magnetization direction of the magnet. The magnet **110a** shown in FIG. **14(a)** is same as the magnet **110a** shown in FIG. **10(b)**. It is shown for comparison with modified examples of other magnets. The magnet **110a** is obtained by dividing a columnar shape into two parts by a plane passing through the axis of a cylindrical column (division: $\frac{1}{2}$). Magnetization directions D_m of individual parts are parallel to the axial direction of the cylindrical column and are in mutually opposite directions. As shown in the first embodiment, the rotation angle that can be detected by the rotation angle detector **1** by using this magnet **110a** is 360° . A magnet **110a1** shown in FIG. **14(b)** is obtained by dividing a columnar shape into four parts by a plane passing through the axis of a cylindrical column (division: $\frac{1}{4}$). Magnetization directions D_m of individual parts are parallel to the axial direction of the cylindrical column and are in mutually opposite directions. Since the magnetic field formed by the magnet **110a1** at a magnetic detection position of the Hall IC **100** has a period of 180° ,

the rotation angle that can be detected by the rotation angle detector **1** by using the magnet **110a1** is 180° . A magnet **110a2** shown in FIG. **14(c)** is obtained by dividing a columnar shape into eight parts by a plane passing through the axis of a cylindrical column (division: $\frac{1}{8}$). Magnetization directions D_m of individual parts are parallel to the axial direction of the cylindrical column and are in mutually opposite directions. Since the magnetic field formed by the magnet **110a2** at a magnetic detection position of the Hall IC **100** has a period of 90° , the rotation angle that can be detected by the rotation angle detector **1** by using the magnet **110a2** is 90° .

[0104] A relationship between the number of divisions and the detection angles shown in FIGS. **14(a)** to **14(c)** described above is similarly applied to the magnet **110** (FIG. **10(a)**), the magnet **110b** (FIG. **11(a)**) and the magnet **110c** (FIG. **11(b)**). Further, in the case of the magnet **110d** (FIG. **12(a)**) or the magnet **110e** (FIG. **12(b)**), the detection angle is further halved.

[0105] Although the magnets **110a**, **110c**, **110e**, **110a1** and **110a2** described above have different magnetization directions for individual parts of the magnet, a plurality of magnets may be prepared and arranged such that the magnetization directions of the adjacent magnets are different from each other. The whole of the magnets may be molded with resin or the like so as to generate the same magnetic field.

[0106] The third embodiment is different from the first embodiment in that a pair of Hall plates configured to detect a magnetic flux density in y direction is added and a rotation angle of a magnet is detected based on a difference in the magnetic flux density in y direction and a difference in the magnetic flux density in x direction. A Hall IC of the third embodiment is applied to the rotation angle detector **1** of the first embodiment. Moreover, the Hall IC of the third embodiment may be applied to the rotation angle detector **1A** of the second embodiment.

[0107] FIGS. **15(a)** to **15(c)** are a perspective view, a plan view and a cross-sectional view showing a configuration of the Hall IC, according to the third embodiment. The Hall IC **100B** comprises: a substrate **100b**; two pairs of magnetic detection elements (a first set of two pairs of magnetic detection elements) consisting of Hall plates **100hl₁** and **100hl₂** (also collectively referred to as a Hall plate **100hlx**) and Hall plates **100hl₃**, **100hl₄** (also collectively referred to as a Hall plate **100hly**) and two pairs of magnetic detection elements (a second set of two pairs of magnetic detection elements) consisting of Hall plates **100hr₁** and **100hr₂** (also collectively referred to as a Hall plate **100hrx**) and Hall plates **100hr₃**, **100hr₄** (also collectively referred to as a Hall plate **100hry**), being provided on the substrate **100b** to have a detection surface parallel to the surface of the substrate **100b** and having a detection direction in a normal direction of the surface of the substrate **100b**; a magnetic concentrator **100sl** provided on the substrate **100b** to overlap on a part of each of the Hall plates **100hlx** and **100hly** and configured to convert magnetic flux in the direction orthogonal to the normal direction into the normal direction to allow the magnetic flux to be detected by the Hall plates **100hlx** and **100hly**; a magnetic concentrator **100sr** provided on the substrate **100b** to overlap on a part of each of the Hall plates **100hrx** and **100hry** and configured to convert magnetic flux in the direction orthogonal to the normal direction into the normal direction to allow the magnetic flux to be

detected by the Hall plates Hall plates **100hrx** and **100hry**; and a signal processing part configured to process signals output from the Hall plates **100hlx**, **100hly**, **100hrx**, and **100hry**, in which the Hall IC **100B** detects magnetic flux densities in x and y directions through signal processing described next.

[0108] A detection operation for the magnetic flux density in y direction is same as the detection operation for the magnetic flux density in x direction described in FIG. 6 and is explained by setting By for horizontal component B// of the drawing of magnetic flux f.

[0109] FIGS. **16(a)** and **16(b)** are graphs showing outputs ΔB_y and ΔB_x of the Hall IC, each relative to the rotation angle of the magnet. Since a relationship between the rotation angle of the magnet and the magnetic field to be formed is same as that in the first embodiment, the description is given with reference to FIGS. **7(a1)** to **7(a5)** and **7(b1)** to **7(b5)**.

[0110] When the rotation angle of the magnet **110** is $\theta=0^\circ$ (FIGS. **7(a1)** and **7(b1)**), magnetic fields B_{yl} and B_{yr} respectively detected by the Hall plate **100hly** and the Hall plate **100hry** have same numerical values. Therefore, $\Delta B_y=0$. Moreover, magnetic fields B_{xl} and B_{xr} respectively detected by the Hall plate **100hlx** and the Hall plate **100hrx** have same numerical values with reverse signs. Therefore, ΔB_x has a negative maximum value.

[0111] Next, when the rotation angle of the magnet **110** is $\theta=90^\circ$ (FIGS. **7(a3)** and **7(b3)**), magnetic fields B_{yl} and B_{yr} respectively detected by the Hall plate **100hly** and the Hall plate **100hry** have same numerical values with reverse signs. Therefore, ΔB_y has a positive maximum value. Moreover, magnetic fields B_{xl} and B_{xr} respectively detected by the Hall plate **100hlx** and the Hall plate **100hrx** have same numerical values. Therefore, $\Delta B_x=0$.

[0112] Next, when the rotation angle of the magnet **110** is $\theta=180^\circ$ (FIGS. **7(a5)** and **7(b5)**), magnetic fields B_{yl} and B_{yr} respectively detected by the Hall plate **100hl** and the Hall plate **100hr** have same numerical values. Therefore, $\Delta B_y=0$. Moreover, magnetic fields B_{xl} and B_{xr} respectively detected by the Hall plate **100hlx** and the Hall plate **100hrx** have same numerical values with reverse signs (opposite to the case of $\theta=0^\circ$). Therefore, ΔB_x has a positive maximum value.

[0113] Considering the behaviour of ΔB_y and ΔB_x above, transition states $\theta=45^\circ$ (FIGS. **7(a2)** and **7(b2)**), $\theta=135^\circ$ (FIGS. **7(a4)** and **7(b4)**), and $\theta=180^\circ$ to 360° , a relationship between rotation angle θ of the magnet **110** and ΔB_y and ΔB_x is such that ΔB_y is proportional to $\sin \theta$, and ΔB_x is proportional to $\cos \theta$, as shown in FIGS. **16(a)** and **16(b)**.

[0114] Namely, $\Delta B_y/\Delta B_x=k' \sin \theta/\cos \theta=k' \tan \theta$, so that $\theta=\arctan (K' \Delta B_y/\Delta B_x)$. Note that k' is a constant for normalizing a magnitude of the amplitude of ΔB_y and ΔB_x , and K' is the reciprocal of k' .

[0115] While the invention has been illustrated and described in detail in the drawings and foregoing description, such illustration and description are to be considered illustrative or exemplary and not restrictive. The foregoing description details certain embodiments of the invention. It will be appreciated, however, that no matter how detailed the foregoing appears in text, the invention may be practiced in many ways. The invention is not limited to the disclosed embodiments.

[0116] Other variations to the disclosed embodiments can be understood and effected by those skilled in the art in

practicing the claimed invention, from a study of the drawings, the disclosure and the appended claims. In the claims, the word “comprising” does not exclude other elements or steps, and the indefinite article “a” or “an” does not exclude a plurality. A single processor or other unit may fulfil the functions of several items recited in the claims. The mere fact that certain measures are recited in mutually different dependent claims does not indicate that a combination of these measures cannot be used to advantage. A computer program may be stored/distributed on a suitable medium, such as an optical storage medium or a solid-state medium supplied together with or as part of other hardware, but may also be distributed in other forms, such as via the Internet or other wired or wireless telecommunication systems. Any reference signs in the claims should not be construed as limiting the scope.

1. An integrated circuit comprising:

a substrate having a surface and comprising a magnetic detection circuit, the magnetic detection circuit comprising:

a first detection point;

a second detection point arranged with a predetermined interval from said first detection point in a direction parallel to said surface of said substrate; and

a signal processing unit configured to provide an output signal based on:

detection of a first magnetic field in said parallel direction to said surface of said substrate at said first detection point,

detection of a second magnetic field in normal direction to said surface of said substrate at said first detection point,

detection of said first magnetic field in said direction parallel to said surface of said substrate at said second detection point, and

detection of said second magnetic field in said normal direction to said surface of said substrate at said second detection point.

2. The integrated circuit as in claim 1, wherein said signal processing unit is arranged to determine a first magnetic flux density difference in said normal direction to said surface and a second magnetic flux density difference in said direction parallel to said surface, said output signal based on said first and said second magnetic flux density difference.

3. The integrated circuit as in claim 2, wherein said signal processing unit is arranged to normalize an amplitude of said first magnetic flux density difference and an amplitude of said second magnetic flux density difference in accordance with a maximum value of said amplitude of said first magnetic flux difference and a maximum value of said amplitude of said second magnetic flux density difference.

4. The integrated circuit as in claim 3, wherein said signal processing unit is operable in a calibration mode to determine the maximum value of an amplitude of said first magnetic flux density difference and the maximum value of an amplitude of said second magnetic flux density difference.

5. The integrated circuit as in claim 2, wherein said first magnetic flux density difference and said second magnetic flux density difference are quadrature signals.

6. An integrated circuit comprising a substrate having a surface and comprising a magnetic detection circuit provided with

a plurality of magnet detection elements; and
a signal processing unit;

wherein the plurality of magnet detection elements are arranged to detect a first magnetic field in a direction parallel to said surface of said substrate at a first detection point, to detect a second magnetic field in normal direction to said surface of said substrate at said first detection point, to detect said first magnetic field in said direction parallel to said surface of said substrate at a second detection point, and to detect said second magnetic field in said normal direction to said surface of said substrate at said second detection point,

wherein said second detection point is arranged with a predetermined interval from said first detection point in said parallel direction to said surface of said substrate, and

wherein the signal processing unit is configured to output a signal based on outputs of said plurality of magnetic detection elements.

7. The integrated circuit as in claim 6, wherein said signal processing unit is arranged to determine a first magnetic flux density difference in said normal direction to said surface and a second magnetic flux density difference in said direction parallel to said surface, from outputs of said plurality of

magnetic detection elements, and to output a signal based on said first and said second magnetic flux density difference.

8. The integrated circuit as in claim 7, wherein said signal processing unit is arranged to normalize an amplitude of said first magnetic flux density difference and an amplitude of said second magnetic flux density difference in accordance with a maximum value of said amplitude of said first magnetic flux density difference and a maximum value of said amplitude of said second magnetic flux density difference.

9. The integrated circuit as in claim 8, wherein said signal processing unit is operable in a calibration mode to determine the maximum value of an amplitude of said first magnetic flux density difference and the maximum value of an amplitude of said second magnetic flux density difference.

10. The integrated circuit as in claim 6, wherein the plurality of magnetic detection elements comprise Hall plates.

11. The integrated circuit as in claim 7, wherein said first magnetic flux density difference and said second magnetic flux density difference are quadrature signals.

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